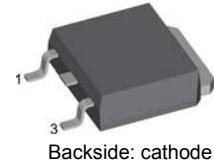
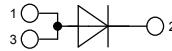


HiPerFRED²

High Performance Fast Recovery Diode
Low Loss and Soft Recovery
Single Diode

V_{RRM} = 300 V
I_{FAV} = 10 A
t_{rr} = 35 ns

Part number**DPG 10 IM 300 UC***Marking on Product: PAOGUI*

Backside: cathode

Features / Advantages:

- Planar passivated chips
- Very low leakage current
- Very short recovery time
- Improved thermal behaviour
- Very low I_{rm}-values
- Very soft recovery behaviour
- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low I_{rm} reduces:
 - Power dissipation within the diode
 - Turn-on loss in the commuting switch

Applications:

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode
- Rectifiers in switch mode power supplies (SMPS)
- Uninterruptible power supplies (UPS)

Package:

- Housing: TO-252 (DPak)
- Industry standard outline
- Epoxy meets UL 94V-0
- RoHS compliant

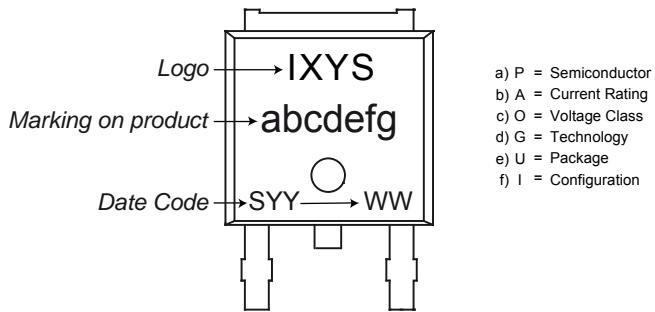
Ratings					
Symbol	Definition	Conditions		min.	typ.
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ\text{C}$			300 V
I_R	reverse current	$V_R = 300\text{V}$ $T_{VJ} = 25^\circ\text{C}$		1 μA	
		$V_R = 300\text{V}$ $T_{VJ} = 150^\circ\text{C}$			
V_F	forward voltage	$I_F = 10\text{A}$ $T_{VJ} = 25^\circ\text{C}$		1.27 V	
		$I_F = 20\text{A}$			
		$I_F = 10\text{A}$ $T_{VJ} = 150^\circ\text{C}$		0.98 V	
		$I_F = 20\text{A}$			
I_{FAV}	average forward current	rectangular	d = 0.5	$T_C = 150^\circ\text{C}$	10 A
V_{F0} r_F	threshold voltage slope resistance } for power loss calculation only			$T_{VJ} = 175^\circ\text{C}$	0.74 V
					18 mΩ
R_{thJC}	thermal resistance junction to case				2.30 K/W
T_{VJ}	virtual junction temperature			-55	175 °C
P_{tot}	total power dissipation			$T_C = 25^\circ\text{C}$	65 W
I_{FSM}	max. forward surge current	t = 10 ms (50 Hz), sine		$T_{VJ} = 45^\circ\text{C}$	140 A
I_{RM}	max. reverse recovery current			$T_{VJ} = 25^\circ\text{C}$	3 A
		$I_F = 10\text{A}; V_R = 200\text{V}$		$T_{VJ} = 125^\circ\text{C}$	5.5 A
t_{rr}	reverse recovery time	$-di_F/dt = 200\text{A}/\mu\text{s}$		$T_{VJ} = 25^\circ\text{C}$	35 ns
				$T_{VJ} = 125^\circ\text{C}$	45 ns
C_J	junction capacitance	$V_R = 150\text{V}; f = 1\text{MHz}$		$T_{VJ} = 25^\circ\text{C}$	15 pF

Symbol	Definition	Conditions	Ratings			
			min.	typ.	max.	
I_{RMS}	RMS current	per pin ¹⁾			20	A
R_{thCH}	thermal resistance case to heatsink			0.50		K/W
T_{stg}	storage temperature		-55		150	°C
Weight				0.3		g
F_c	mounting force with clip		20		60	N

¹⁾ I_{RMS} is typically limited by: 1. pin-to-chip resistance; or by 2. current capability of the chip.

In case of 1, a common cathode/anode configuration and a non-isolated backside, the whole current capability can be used by connecting the backside.

Product Marking



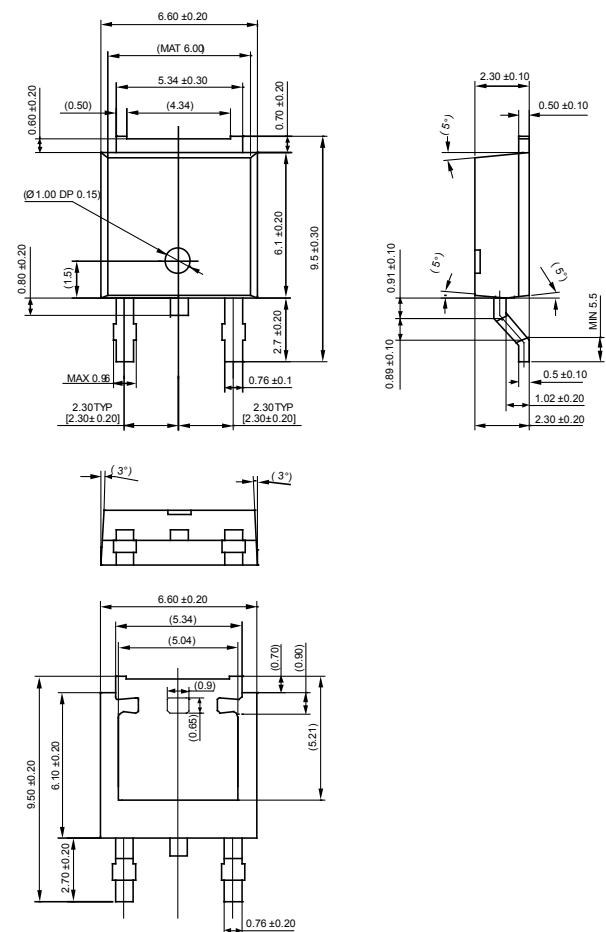
Part number

D = Diode
 P = HiPerFRED
 G = extreme fast
 10 = Current Rating [A]
 IM = Single Diode
 300 = Reverse Voltage [V]
 UC = TO-252AA (DPak)

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Code Key
Standard	DPG 10 IM 300 UC	PAOGUI	Tape & Reel	2500	505682

Similar Part	Package	Voltage Class
DPG10I300PA	TO-220AC (2)	300

Outlines TO-252 (DPak)



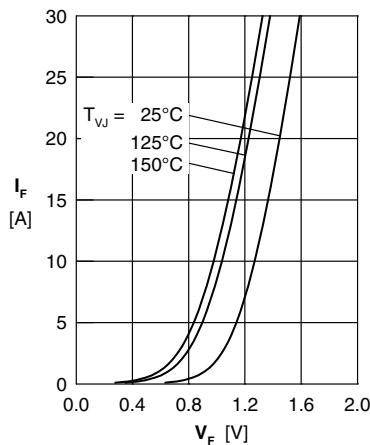


Fig. 1 Forward current I_F vs. V_F

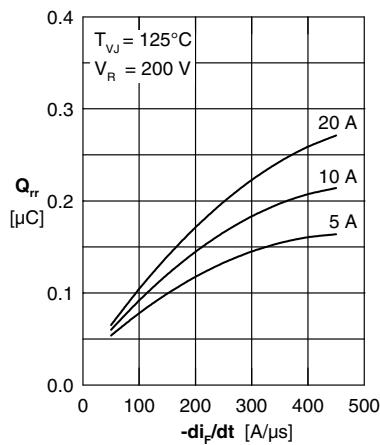


Fig. 2 Typ. reverse recovery charge Q_{rr} versus $-di_F/dt$

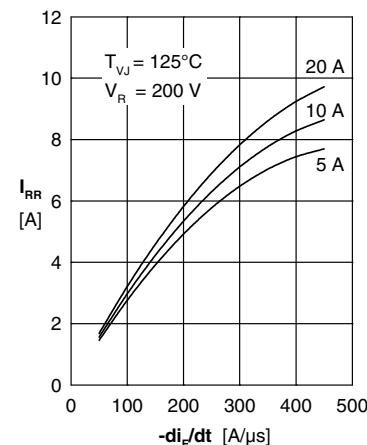


Fig. 3 Typ. peak reverse current I_{RR} versus $-di_F/dt$

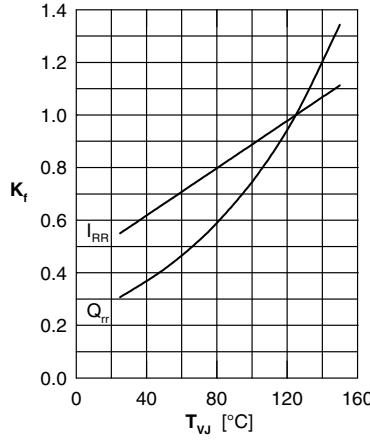


Fig. 4 Dynamic parameters Q_{rr} , I_{RR} versus T_{vJ}

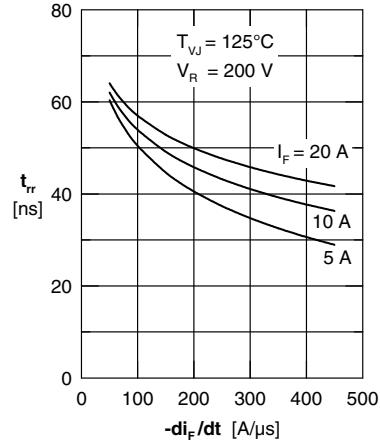


Fig. 5 Typ. recovery time t_{rr} vs. $-di_F/dt$

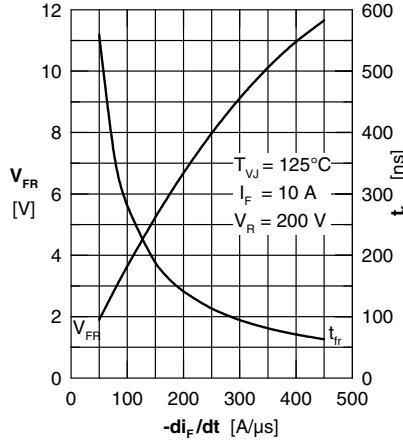


Fig. 6 Typ. peak forward voltage V_{fr} and t_{rr} versus di_F/dt

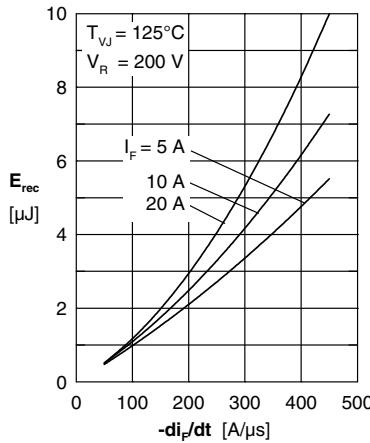


Fig. 7 Typ. recovery energy E_{rec} versus $-di_F/dt$

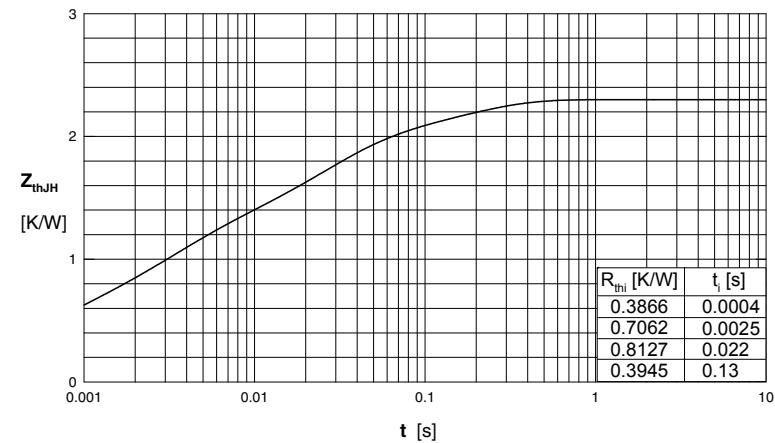


Fig. 8 Transient thermal resistance junction to case